

## P-Channel 30 V (D-S) MOSFET

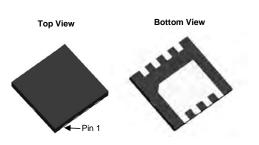
V <sub>DS</sub>		-30	V
R <sub>DS(on),typ</sub>	V <sub>GS</sub> =10V	11	mΩ
R <sub>DS(on),typ</sub>	V <sub>GS</sub> =4.5V	18	mΩ
ID	-45	А	

#### **FEATURES**

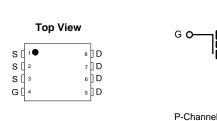
- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- Low Thermal Resistance PowerPAK<sup>®</sup> Package with Small Size and Low 1.07 mm Profile
- 100 %  $\rm R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

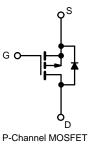
#### **APPLICATIONS**

- · Load Switch
- Adaptor Switch
- Notebook PC



DFN 3x3 EP





Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	v	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		- 45		
Continuous Drain Current ( $T_J = 150 \ ^{\circ}C$ )	T <sub>C</sub> = 70 °C		- 30		
Continuous Drain Guirent (1) = 150°C)	T <sub>A</sub> = 25 °C		- 14.4 <sup>a, b</sup>		
	T <sub>A</sub> = 70 °C		- 11.5 <sup>a, b</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	- 60	A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	- 35 <sup>e</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is Is	- 3.2 <sup>a, b</sup>		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 25		
Single-Pulse Avalanche Energy		E <sub>AS</sub>	31.25	mJ	
	T <sub>C</sub> = 25 °C		52		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	43	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	'D	3.8 <sup>a, b</sup>	VV	
	T <sub>A</sub> = 70 °C		2.4 <sup>a, b</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 50 to 150	℃	
Soldering Recommendations (Peak Temperature) <sup>c, d</sup>			260	-0	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c.Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

d.Package limited.

e.Based on T  $_{\rm C}$  = 25 °C



THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	26	33	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R <sub>th</sub> IC	1.9	2.4	0/10	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under Steady State conditions is 81 °C/W.

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)						11	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 20		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	5 .		5		1110/ 0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	- 1.5		- 2.8	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zoro Cato Voltago Drain Current	lace	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	μA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 V, V_{GS} = -10 V$	- 20			Α	
	_	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14.4 A		11		mΩ	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 11.5 A		18			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 14.4 A		37		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			2000		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		385			
Reverse Transfer Capacitance	C <sub>rss</sub>			322			
·		$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -14.4 \text{ A}$			15	nC	
Total Gate Charge	Qg				14		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 14.4 A			7		
Gate-Drain Charge	Q <sub>qd</sub>				9		
Gate Resistance	R <sub>q</sub>	f = 1 MHz	0.4	1.8	3.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		0.1	50	75		
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, \text{ R}_{1} = 1.5 \Omega$		43	65	-	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{a}} = 1 \Omega$		30	45		
Fall Time	t <sub>f</sub>	$D = 1000$ , $V_{GEN} = 1000$ , $N_g = 1000$		14	21		
Turn-On Delay Time				14	21	ns	
Rise Time	t <sub>d(on)</sub>	$V_{DD} = -15 \text{ V}, \text{ R}_{1} = 1.5 \Omega$		9	18	-	
Turn-Off DelayTime	t <sub>r</sub>	$I_D \cong -10 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		36	54		
	t <sub>d(off)</sub>	$D = -10 \text{ A}, V_{\text{GEN}} = -10 \text{ V}, H_{\text{g}} = 1.52$					
Fall Time	t <sub>f</sub>			10	20		
Drain-Source Body Diode Characterist		T 05 %0			0	1	
Continuous Source-Drain Diode Current	ا <sub>S</sub>	T <sub>C</sub> = 25 °C			- 35 <sup>e</sup>	A	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 60		
Body Diode Voltage	V <sub>SD</sub>	I <sub>F</sub> = - 10 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	l		31	47	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>.1</sub> = 25 °C		30	45	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			15		ns	
Reverse Recovery Rise Time	t <sub>b</sub>	7		16		115	

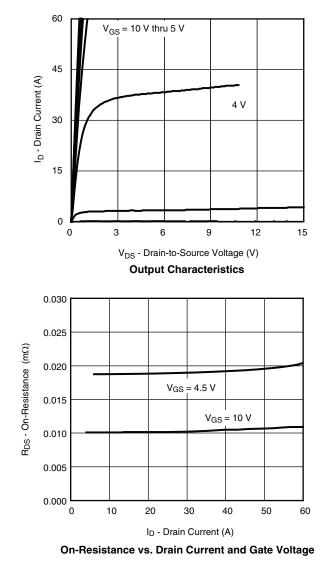
Notes:

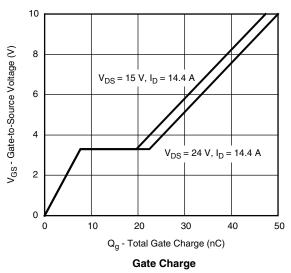
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

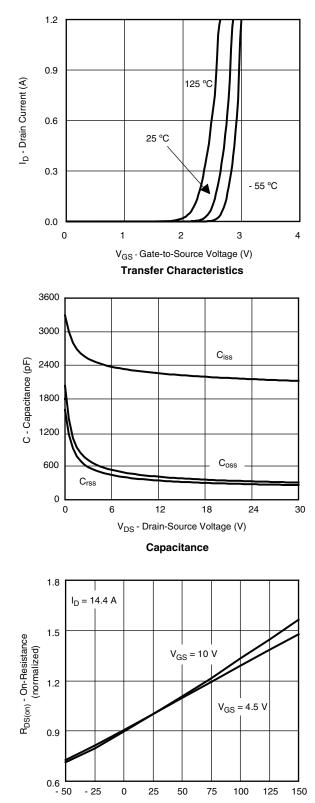
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





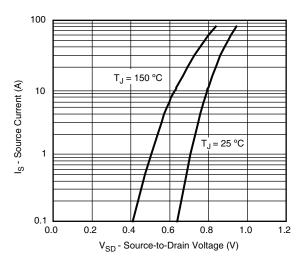


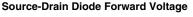


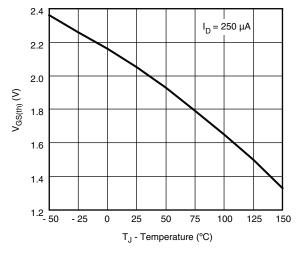
T<sub>J</sub> - Junction Temperature (°C) **On-Resistance vs. Junction Temperature** 

- 25

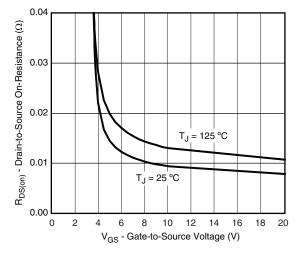




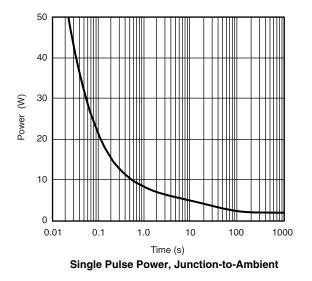


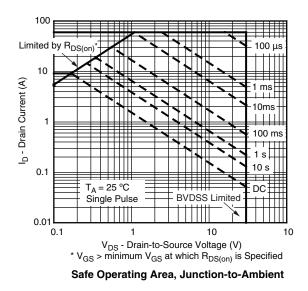




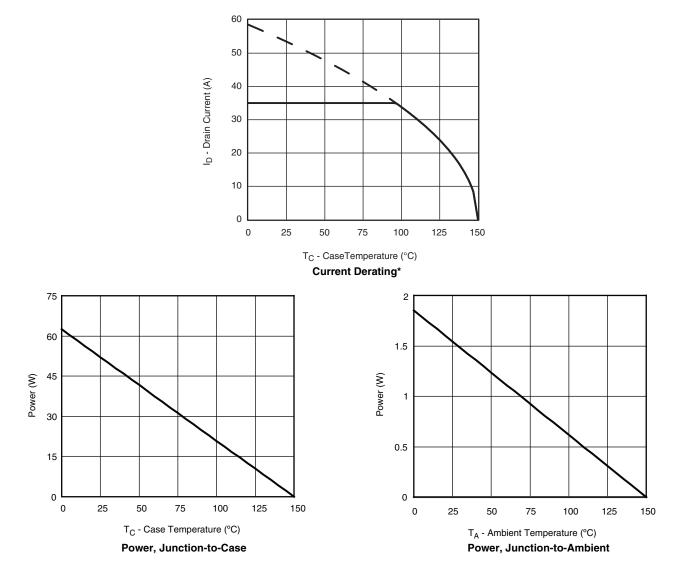


On-Resistance vs. Gate-to-Source Voltage



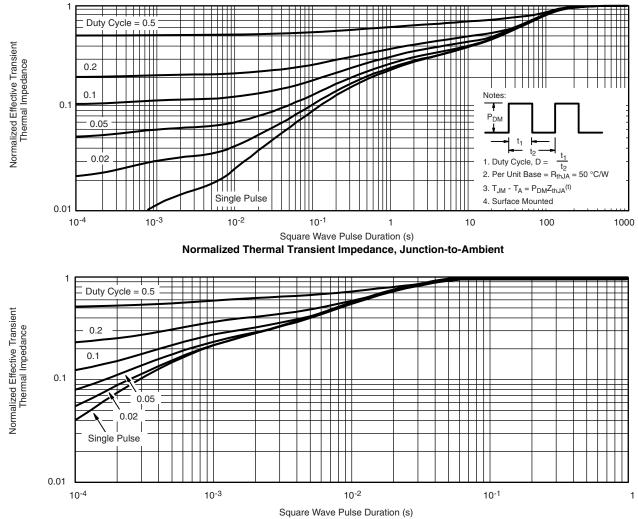






\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

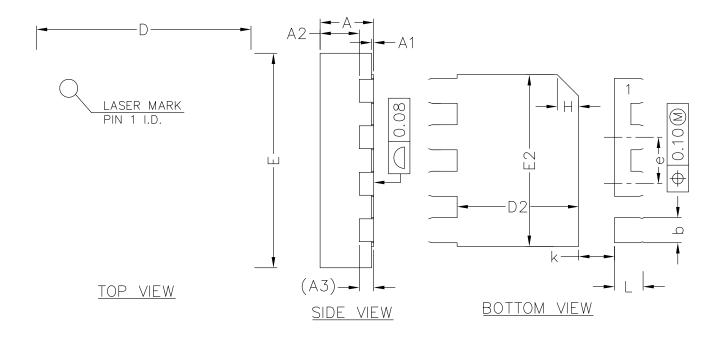




Normalized Thermal Transient Impedance, Junction-to-Case

### VBZQA50P03

B<sup>®</sup>VBsemi www.VBsemi.com





<u>SIDE VIEW</u>

SYMBOL	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.50	0.55	0.60
A3		0.20REF	
b	0.30	0.35	0.40
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	1.60	1.70	1.80
E2	2.30	2.40	2.50
е	0.55	0.65	0.75
К	0.40	0.50	0.60
L	0.35	0.40	0.45

# COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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